Very Long Wavelength In_xGa_{1-x}As/GaAs Quantum Well Infrared Photodetectors

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ABSTRACT

For all of the GaAs based Quantum Well Infrared Photodetectors (QWIP) which have been demonstrated so far, GaAs is the low band gap well material and the barriers are lattice matched Al_xGa_{1-x}As, Ga_{0.5}In_{0.5}P or Al_{0.5}In_{0.5}P. However, it is also interesting to consider GaAs as the barrier material since the transport in binary GaAs is expected to be superior to that of a ternary alloy, as was previously found to be the case in the In_{0.53}Ga_{0.47}As/InP binary barrier structures ¹. To achieve this we have used the lower bandgap non-lattice matched alloy In_xGa_{1-x}As as the well material. Excellent quality strained layer OWIPs having compositions Ino.15Gao.85As/GaAS and In 2 Gao 8 As/GaAs were grown by molecular beam epitaxy. The measured absolute responsivity of these QWIPS increases nearly linearly with bias reaching 0.63 A/W at Vb = -150 mV. The measured optical gain is also very large reaching g = 12 at Vb = -100mV which corresponds to a small capture probability of 2.7%. This excellent hot-electron transport is due to the high mobility of binary GaAs barriers. The measured defectivity of these unoptimized detectors (λ_c = 20 μ m) at temperature T = 20 K are about lx 10¹¹ cm\Hz/W. This demonstrates the excellent carrier transport of the GaAs barriers and the potential of this heterobarrier system for very long wavelength ($\lambda > 14 \mu m$) QWIPS.

1. S. D. Gunapala, B. F. Levine, D. Ritter, R. A. Harem, and M. B. Panish, Appl. Phys. Lett. 58,2024 (1991).